Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/748,164	TAKANO ET AL.	
Examiner	Art Unit	
John m. Cooney	1711	

	SEAR	CHED	
Class	Subclass	Date	Examiner
521	128,129	6/05	MC

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
	<u> </u>					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST /Ask.com				
Inventor	6/05	MC		
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